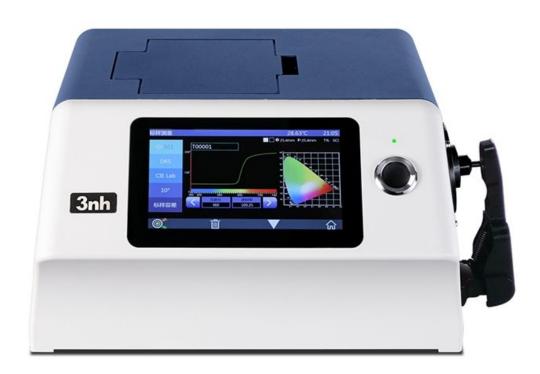
## 3nh<sup>®</sup>



YS6080 Pulsed Xenon lamp Benchtop Spectrophotometer YS6080 is a benchtop grating spectrophotometer which is developed by 3nh independently with independent intellectual property. YS6080 has many features, like 7 inches TFT capacitive touch screen display, full illuminants, reflective d/8 and transmissive d/0 geometry (including or excluding UV). With very stable and precise color measurement, large storage and powerful PC software all makes YS6080 ideal for color analysis within R&D and laboratory environments.

## **Features**

- 1, High configuration of hardware: 7 inches TFT Color Capacitive Touch-screen Display; Bluetooth 2.1; Concave Grating.
- 2, Double Array 256 Image Element CMOS Sensor; Long life-span stable xenon lamp.
- 3, With reflective and transmissive spectrum, accurate Lab value, good to calculate color formula and do precise color transmission.
- 4, Auto identify measuring aperture. Freely switchable between 3 measuring apertures: Φ 25.4mm/8mm/4mm. Users also can customize apertures.
- 5, Built-in temperature sensor to monitor and compensate the measuring temperature to ensure the measurement more precision.
- 6, Wavelength range 360nm 780nm. Built-in 400nm/420nm/460nm cut off Xenon lamp, more professional in UV measurement.
- 7, Independent light source detector, continuously monitor the condition of light sources to ensure the light source reliable.
- 8, Multiple measurement modes: Quality Management Mode, Sample Mode; Meet more users' requirement.
- 9,A variety of optional accessories: Reflection sample holding tool, transmission fixture, micro 4mm aperture transmission test components, instrument inversion test components, applicable to more working conditions.
- 10, Big capacity data storage, for 20000 pieces test result.
- 11, Built-in camera locating.
- 12, More powerful extended functions at the PC software.

## **Application Industry**

YS6080 benchtop spectrophotometer is used to do precise color analysis and transmission in laboratories. It can be widely applied in different industries, such as plastics, electronics, paint and ink, printing, garments, leather, paper, auto, medical, cosmetics, food, science institutes, laboratories.

SCI (specular component included)/SCE (specular component excluded), include UV / excluded UV light source;  Transmittance: di.0°, de.0° (diffuse illumination: 0° viewing); SCI (specular component included)/SCE (specular component excluded), include UV / excluded UV light source; Haze(ASTM D1003); Conforms to CIE No.15, GB/T 3978, GB 2893, GB/T 18833, ISO7724/1, ASTM E1164, DIN5033 Teil7  Integrating Sphere Φ 154mm Size Light Source Device Xenon Lamp, 400nm cut-off Xenon Lamp, 420nm cut-off Xenon Lamp, 460nm cut-off Xenon Lamp Spectrophotometric Concave Gratting  Goneave Gratting  Concave Gratting  Goneave Gratting	Model	YS6080(Pulsed xenon lamp)
Conforms to CIE No.15, GB/T 3978,GB 2893,GB/T 18833, ISO7724/1, ASTM E1164, DIN5033 Teil7  Integrating Sphere Φ 154mm Size  Light Source Device 360nm-780nm Xenon Lamp, 400nm cut-off Xenon Lamp,420nm cut-off Xenon Lamp,460nm cut-off Xenon Lamp Spectrophotometric Mode  Sensor 256 Image Element Double Array CMOS Image Sensor  Wavelength Range 360-780nm Wavelength Pitch 10nm Semiband Width 5nm Reflectance Range 0~200%  Measuring Aperture Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm; Transmissive : Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE Transmittance: SCI&SCE Transmittance: SCI&SCE Color Space CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔE*ab, ΔE*uv, ΔE*94, ΔE*cmc(2:1), ΔE*cmc(1:1), ΔE*00v, ΔE(Hunter), VI (ASTM D1925, ASTM 313), TI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10°  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Optical Geometry	SCI (specular component included)/SCE (specular component excluded);Include UV / excluded UV light source; Transmittance: di:0°, de:0° (diffuse illumination: 0° viewing); SCI (specular component included)/SCE (specular component excluded);Include UV / excluded UV light source;
Size  Light Source Device  360nm-780nm Xenon Lamp, 400nm cut-off Xenon Lamp,420nm cut-off Xenon Lamp  Spectrophotometric  Mode  Sensor  256 Image Element Double Array CMOS Image Sensor  Wavelength Range  Wavelength Pitch  10nm  Semiband Width  Snm  Reflectance Range  0~200%  Measuring Aperture  Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm;  Transmissive : Φ30mm/Φ25.4mm, Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE  Transmittance: SCI&SCE  Color Space  CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, Hunterlab, DIN, βxy  Color Difference ΔE*ab, ΔE*uv, ΔE*94, ΔE*cmc(2:1), ΔE*cmc(1:1), ΔE*00v, ΔE(Hunter), DIN ΔE99  Colorimetric Index  WI (ASTM E313, CIE/ISO), AATCC, Hunter),  YI (ASTM E313, CIE/ISO),  MI (Metamerism Index),  Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle  2° & 10°  Displayed Data  Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset		Conforms to CIE No.15, GB/T 3978,GB 2893,GB/T 18833, ISO7724/1,
Xenon Lamp,460nm cut-off Xenon Lamp  Spectrophotometric Mode  Sensor 256 Image Element Double Array CMOS Image Sensor  Wavelength Range 360-780nm  Wavelength Pitch 10nm  Semiband Width 5nm  Reflectance Range 0~200%  Measuring Aperture Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm;  Transmissive : Φ30mm/Φ25.4mm, Emark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE  Transmittance: SCI&SCE  Transmittance: SCI&SCE  Color Space CIE Lab, XYZ, Xyz, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔΕ*ab, ΔΕ*uv, ΔΕ*94, ΔΕ*cmc(2:1), ΔΕ*cmc(1:1), ΔΕ*00v, ΔΕ(Hunter), DIN ΔΕ99  Colorimetric Index WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10°  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Integrating Sphere	Ф 154mm
Mode Sensor  256 Image Element Double Array CMOS Image Sensor  Wavelength Range 360-780nm  Wavelength Pitch 10nm Semiband Width 5nm  Reflectance Range 0~200%  Measuring Aperture Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm; Transmissive : Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE Transmittance: SCI&SCE Color Space CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔE*ab, ΔE*uv, ΔE*94, ΔE*cmc(2:1), ΔE*cmc(1:1), ΔE*00v, ΔE(Hunter), DIN ΔE99  Colorimetric Index WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10° Ulluminants D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Light Source Device	
Wavelength Range 360-780nm  Wavelength Pitch 10nm  Semiband Width 5nm  Reflectance Range 0~200%  Measuring Aperture Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm;	Spectrophotometric Mode	Concave Grating
Wavelength Pitch Semiband Width Semiband Width Snm Reflectance Range O~200% Measuring Aperture Reflective: Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm; Transmissive: Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE Transmittance: SCI&SCE Color Space CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔΕ*ab, ΔΕ*uv, ΔΕ*94, ΔΕ*cmc(2:1), ΔΕ*cmc(1:1), ΔΕ*00v, ΔΕ(Hunter), DIN ΔΕ99 Colorimetric Index WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10° Illuminants D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Sensor	256 Image Element Double Array CMOS Image Sensor
Semiband Width  Reflectance Range  0~200%  Measuring Aperture  Reflective: Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm;  Transmissive: Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component  Reflectance: SCI&SCE  Transmittance: SCI&SCE  Color Space  CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔE*ab, ΔE*uv, ΔE*94, ΔE*cmc(2:1), ΔE*cmc(1:1), ΔE*00v, ΔE(Hunter), DIN ΔE99  Colorimetric Index  WI (ASTM E313, CIE/ISO, AATCC, Hunter),  YI (ASTM D1925, ASTM 313),  TI (ASTM E313, CIE/ISO),  MI (Metamerism Index),  Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle  2° & 10°  Illuminants  D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data  Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Wavelength Range	360-780nm
Reflectance Range 0~200%  Measuring Aperture Reflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm;  Transmissive : Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens position  Specular Component Reflectance: SCI&SCE  Transmittance: SCI&SCE  Color Space CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔΕ*ab, ΔΕ*uv, ΔΕ*94, ΔΕ*cmc(2:1), ΔΕ*cmc(1:1), ΔΕ*00v, ΔΕ(Hunter), DIN ΔΕ99  Colorimetric Index WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10°  Illuminants D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Wavelength Pitch	10nm
Measuring ApertureReflective : Φ30mm/Φ25.4mm, Φ18mm/Φ15mm, Φ10mm/Φ8mm, Φ6mm/Φ4mm; Transmissive : Φ30mm/Φ25mm;Remark: 1. Automatic identification of switch caliber 2. Customized Configuration caliber and lens positionSpecular ComponentReflectance: SCI&SCE Transmittance: SCI&SCEColor SpaceCIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxyColorDifference ΔE*ab, ΔE*uv, ΔE*94, ΔE*cmc(2:1), ΔE*cmc(1:1), ΔE*00v, ΔE(Hunter), DIN ΔE99Colorimetric IndexWI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)Observer Angle2° & 10°IlluminantsD65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12Displayed DataSpectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Semiband Width	5nm
### Pransmissive : ### Pransmis	Reflectance Range	0~200%
Transmittance: SCI&SCE  Color Space  CIE Lab, XYZ, Yxy, LCh, CIE LUV, Hunter LAB, Munsell, s-RGB, HunterLab, DIN, βxy  Color Difference ΔΕ*ab, ΔΕ*uv, ΔΕ*94, ΔΕ*cmc(2:1), ΔΕ*cmc(1:1), ΔΕ*00ν, ΔΕ(Hunter), DIN ΔΕ99  Colorimetric Index  WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle  2° & 10°  Illuminants  D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data  Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Measuring Aperture	Φ6mm/Φ4mm; Transmissive : Φ30mm/Φ25mm;Remark: 1. Automatic identification of
HunterLab, DIN, βxy  Color Difference ΔΕ*ab, ΔΕ*uv, ΔΕ*94, ΔΕ*cmc(2:1), ΔΕ*cmc(1:1), ΔΕ*00v, ΔΕ(Hunter), Formula DIN ΔΕ99  Colorimetric Index WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10°  Illuminants D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Specular Component	
FormulaDIN ΔΕ99Colorimetric IndexWI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)Observer Angle2° & 10°IlluminantsD65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12Displayed DataSpectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Color Space	
Colorimetric Index  WI (ASTM E313, CIE/ISO, AATCC, Hunter), YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle  2° & 10°  Illuminants  D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data  Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Color Difference	$\Delta$ E*ab, $\Delta$ E*uv, $\Delta$ E*94, $\Delta$ E*cmc(2:1), $\Delta$ E*cmc(1:1), $\Delta$ E*00v, $\Delta$ E(Hunter),
YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity, Gardner Index, Pt-Co Index, 555 Index, Haze(ASTM D1003)  Observer Angle 2° & 10°  Illuminants D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Formula	DIN ΔΕ99
D65, A, C, UV, D50, D55, D75, F1, F2, F3, F4, F5, F6, F7, F8, F9, F10, F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Colorimetric Index	YI (ASTM D1925, ASTM 313), TI (ASTM E313, CIE/ISO), MI (Metamerism Index), Staining Fastness, Color Fastness, Color Strength, Opacity,
F11, F12  Displayed Data Spectrogram/Values, Chromaticity Values, Color Difference Values/Graph, Pass/Fail Result, Color Offset	Observer Angle	2° & 10°
Values/Graph, Pass/Fail Result, Color Offset	Illuminants	
Measuring Time About 2.4s (Measure SCI & SCE about 5s)	Displayed Data	
	Measuring Time	About 2.4s (Measure SCI & SCE about 5s)

Repeatability	Spectral reflectance: Φ25.4mm/SCI, Standard deviation within 0.06% (400 nm to 700 nm: within 0.05%)
	Chromaticity value: Φ25.4mm/SCI, Standard deviation within ΔE*ab
	0.012 (When a white calibration plate is measured 30 times at 5 second
	intervals after white calibration)
	Spectral Transmittance: Φ25.4mm/SCI, Standard deviation within 0.06%
	(400 nm to 700 nm: within 0.06%)
	Chromaticity value: Φ25.4mm/SCI, Standard deviation within ΔE*ab
	0.015 (When a white calibration plate is measured 30 times at 5 second
	intervals after white calibration)
Inter-instrument Error	Φ25.4mm/SCI, Within ΔE*ab 0.12
	(Average for 12 BCRA Series II color tiles)
Size	370×300×200mm
Weight	About 9.6kg
Power Supply	DC 24V, 3A Power Adapter
Light Source Device	5 years, more than 3 million times measurements.
Life	
Display	7" TFT Capacitive Screen-touch Display
Data Port	USB & Bluetooth & Print serial port
Data Storage	Standard 5000 Pcs, Sample 40000 Pcs
Language	Simplified Chinese, Traditional Chinese, English, (Optional Customized
	German, French and Spanish)
Working Environment	Temperature: 0~40°C; Humidity: 0~85% (No Condensation)
Storage Environment	Temperature: -20~50°C; Humidity: 0~85% (No Condensation)
Standard Accessory	Power Adapter, User Guide, CD Disk(PC Software), USB cable, Standard Calibration Board, Black Calibration Cavity, Transmission black baffle, Sample holder, 25.4 caliber, 15 caliber, 8 caliber, 4 caliber, Transmissive Test Component
	Micro-printer, Micro Aperture(4mm) transmission test clamp component, Instrument inversion components
Notes: The specificati	ons are subject to change without notice.